

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/626,969	FLICK, KENNETH E.	
Examiner		Art Unit		Page 1 of 1
Brent A Swarthout		2636		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,028,537	02-2000	Suman et al.	340/988
	B	US-6,100,792	08-2000	Ogino et al.	340/426.25
	C	US-5,990,786	11-1999	Issa et al.	340/429
	D	US-5,084,697	01-1992	Hwang, Shih-Ming	340/541
	E	US-5,216,407	06-1993	Hwang, Shih-Ming	340/426.22
	F	US-6,392,534	05-2002	Flick, Kenneth E.	340/426.17
	G	US-6,297,731	10-2001	Flick, Kenneth E.	340/426.16
	H	US-6,275,147	08-2001	Flick, Kenneth E.	340/426.25
	I	US-6,249,216	06-2001	Flick, Kenneth E.	340/426.14
	J	US-6,243,004	06-2001	Flick, Kenneth E.	340/426.25
	K	US-6,011,460	01-2000	Flick, Kenneth E.	340/426.25
	L	US-5,719,551	02-1998	Flick, Kenneth E.	340/426.25
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.